

MOS FIELD EFFECT TRANSISTOR 2SK3062

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3062 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Low on-state resistance
 - $R_{\text{DS(on)1}}$ = 8.5 $m\Omega$ MAX. (Vgs = 10 V, Ip = 35 A)
 - RDS(on)2 = 12 m Ω MAX. (VGS = 4.0 V, ID = 35 A)
- Low Ciss: Ciss = 5200 pF TYP.
- Built-in gate protection diode

★ ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK3062	TO-220AB
2SK3062-S	TO-262
2SK3062-ZJ	TO-263
2SK3062-Z	TO-220SMD

Notes TO-220SMD package is produced only in Japan

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	60	V
Gate to Source Voltage (Vps = 0 V)	Vgss(ac)	±20	V
Gate to Source Voltage (Vps = 0 V)	VGSS(DC)	+20, -10	V
Drain Current (DC) (Tc = 25°C)	I _{D(DC)}	±70	Α
Drain Current (Pulse) Note1	ID(pulse)	±280	Α
Total Power Dissipation (Tc = 25°C)	PT	100	W
Total Power Dissipation (T _A = 25°C)	Рт	1.5	W
Channel Temperature	T_ch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	35	Α
Single Avalanche Energy Note2	Eas	122.5	mJ

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1 %

2. Starting Tch = 25 °C, V_{DD} = 30 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V

(TO-220AB)



(TO-262)



(TO-263, TO-220SMD)



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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

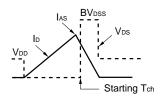


ELECTRICAL CHARACTERISTICS (TA = 25 °C)

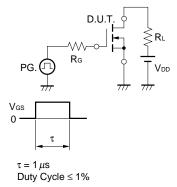
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 60 V, V _{GS} = 0 V			10	μΑ
Gate Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.0	1.5	2.0	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 35 A	20	87		S
Drain to Source On-state Resistance	RDS(on)1	Vss = 10 V, lb = 35 A		6.3	8.5	mΩ
	RDS(on)2	Vgs = 4.0 V, ID = 35 A		8.2	12	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		5200		pF
Output Capacitance	Coss	Vss = 0 V		1300		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		480		pF
Turn-on Delay Time	td(on)	V _{DD} = 30 V ,I _D = 35 A		75		ns
Rise Time	tr	V _{GS(on)} = 10 V		1150		ns
Turn-off Delay Time	td(off)	$R_G = 10 \Omega$		360		ns
Fall Time	tr			480		ns
Total Gate Charge	QG	VDD = 48 V		95		nC
Gate to Source Charge	Qgs	V _{GS(on)} = 10 V		13		nC
Gate to Drain Charge	Q _{GD}	ID = 70 A		30		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 70 A, VGS = 0 V		0.97		V
Reverse Recovery Time	trr	IF = 70 A, Vgs = 0 V		70		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		140		nC

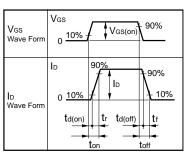
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$R_{G} = 25 \Omega$ PG. $V_{GS} = 20 \rightarrow 0 \text{ V}$ $V_{DS} = 20 \rightarrow 0 \text{ V}$ $V_{DS} = 20 \rightarrow 0 \text{ V}$



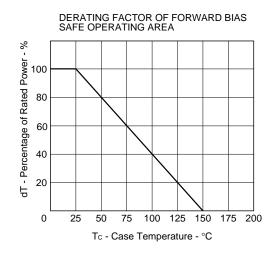
TEST CIRCUIT 2 SWITCHING TIME

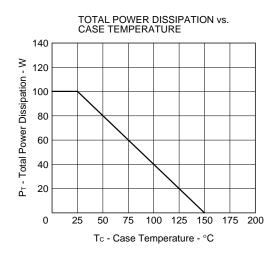


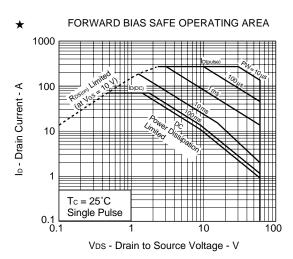


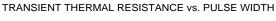
TEST CIRCUIT 3 GATE CHARGE

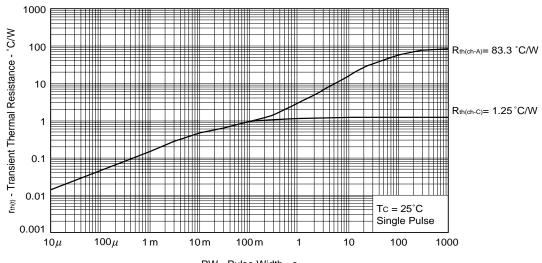
TYPICAL CHARACTERISTICS (TA = 25 °C)





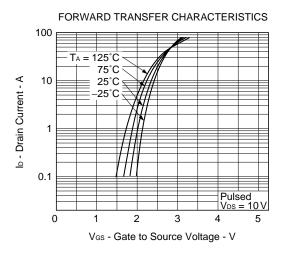


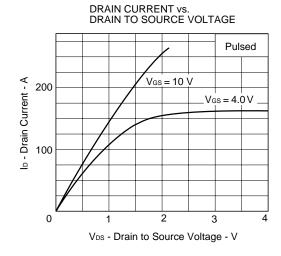


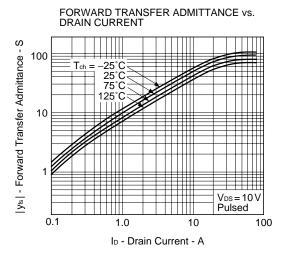


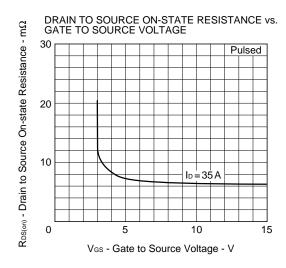
PW - Pulse Width - s

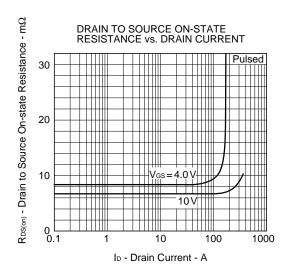
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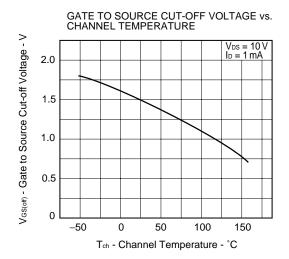


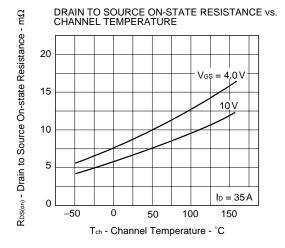


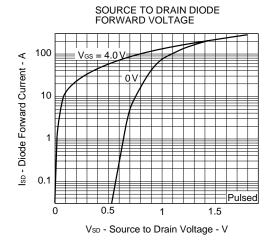


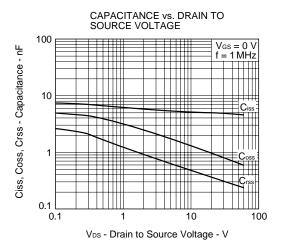


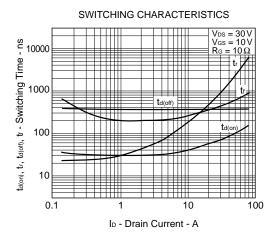


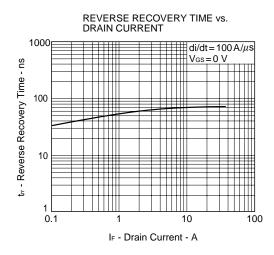


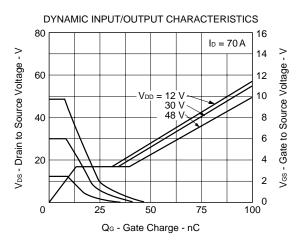


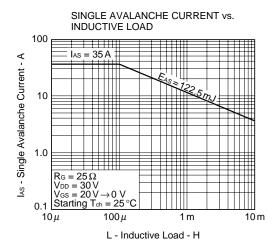


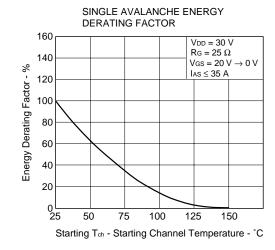








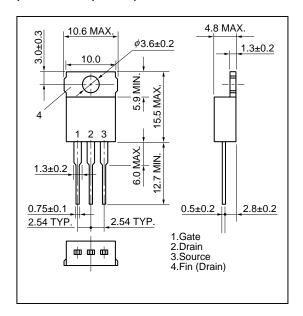




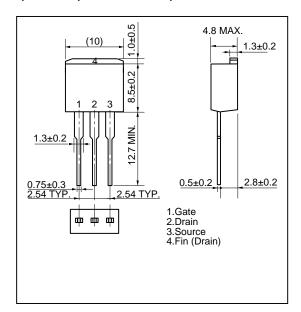


PACKAGE DRAWINGS (Unit: mm)

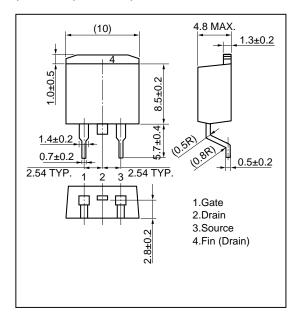
1)TO-220AB (MP-25)



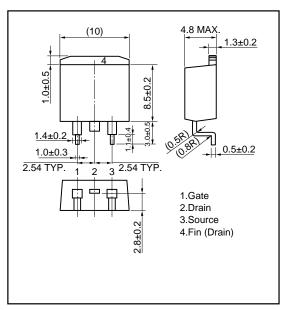
2)TO-262 (MP-25 Fin Cut)



3)TO-263 (MP-25ZJ)

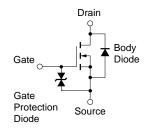


4) TO-220SMD(MP-25Z)^{Note}



Note This Package is produced only in Japan.

EQUIVALENT CIRCUIT



Remark

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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